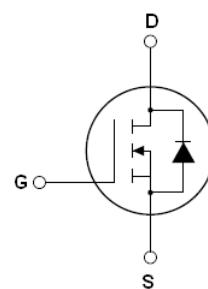


**Features:**

- Advanced trench process technology
- Ultra low  $R_{dson}$ , typical 5mohm
- High avalanche energy, 100% test
- Fully characterized avalanche voltage and current

**ID =84A  
BV=68V  
 $R_{dson}=8\text{mohm}$**


**Description:**

The SSF6808A is a new generation of middle voltage and high current N-Channel enhancement mode trench power MOSFET. This new technology increases the device reliability and electrical parameter repeatability. SSF6808A is assembled in high reliability and qualified assembly house.


**Application:**

- Power switching application

**SSF6808A TOP View (TO-263)**

**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D@T_c=25\text{ }^\circ\text{C}$	Continuous drain current,VGS@10V	84	A
$I_D@T_c=100\text{ }^\circ\text{C}$	Continuous drain current,VGS@10V	76	
$I_{DM}$	Pulsed drain current ①	310	
$P_D@T_c=25\text{ }^\circ\text{C}$	Power dissipation	180	W
	Linear derating factor	1.5	W/ $^\circ\text{C}$
$V_{GS}$	Gate-to-Source voltage	$\pm 20$	V
$dv/dt$	Peak diode recovery voltage	31	v/ns
$E_{AS}$	Single pulse avalanche energy ②	400	mJ
$E_{AR}$	Repetitive avalanche energy	TBD	
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ\text{C}$

**Thermal Resistance**

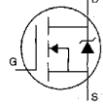
	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case	—	0.83	—	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-ambient	—	—	62	

**Electrical Characteristics @ $T_J=25\text{ }^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$BV_{DSS}$	Drain-to-Source breakdown voltage	68	—	—	V	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	5	8	$\text{m}\Omega$	$V_{GS}=10\text{V}, I_D=30\text{A}$
$V_{GS(th)}$	Gate threshold voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
$I_{DSS}$	Drain-to-Source leakage current	—	—	2	$\mu\text{A}$	$V_{DS}=68\text{V}, V_{GS}=0\text{V}$
		—	—	10		$V_{DS}=68\text{V}, V_{GS}=0\text{V}, T_J=150\text{ }^\circ\text{C}$

I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	nA	V <sub>GS</sub> =20V
	Gate-to-Source reverse leakage	—	—	-100		V <sub>GS</sub> =-20V
Q <sub>g</sub>	Total gate charge	—	90	—	nC	I <sub>D</sub> =30A
Q <sub>gs</sub>	Gate-to-Source charge	—	18	—		V <sub>DD</sub> =30V
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	28	—		V <sub>GS</sub> =10V
t <sub>d(on)</sub>	Turn-on delay time	—	18.2	—	nS	V <sub>DD</sub> =30V
t <sub>r</sub>	Rise time	—	15.6	—		I <sub>D</sub> =2A , R <sub>L</sub> =15Ω
t <sub>d(off)</sub>	Turn-Off delay time	—	70.5	—		R <sub>G</sub> =2.5Ω
t <sub>f</sub>	Fall time	—	13.8	—		V <sub>GS</sub> =10V
C <sub>iss</sub>	Input capacitance	—	3150	—	pF	V <sub>GS</sub> =0V
C <sub>oss</sub>	Output capacitance	—	300	—		V <sub>DS</sub> =25V
C <sub>rss</sub>	Reverse transfer capacitance	—	240	—		f=1.0MHZ

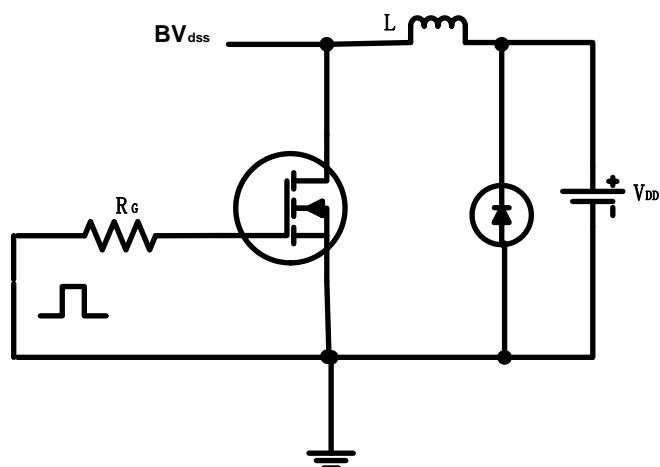
### Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	84	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	310		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.3	V	T <sub>J</sub> =25C, I <sub>S</sub> =68A, V <sub>GS</sub> =0V ③
t <sub>rr</sub>	Reverse Recovery Time	—	57	—	nS	T <sub>J</sub> =25C, I <sub>F</sub> =68A di/dt=100A/μs ③
Q <sub>rr</sub>	Reverse Recovery Charge	—	107	—	nC	
t <sub>on</sub>	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>s</sub> + LD)				

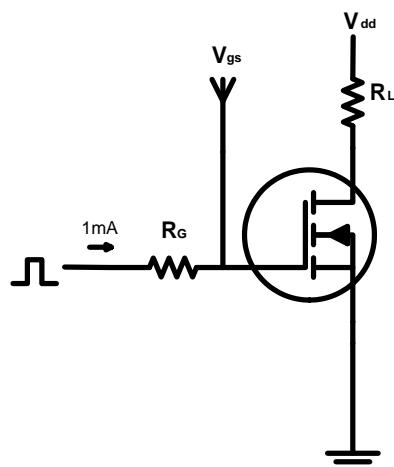
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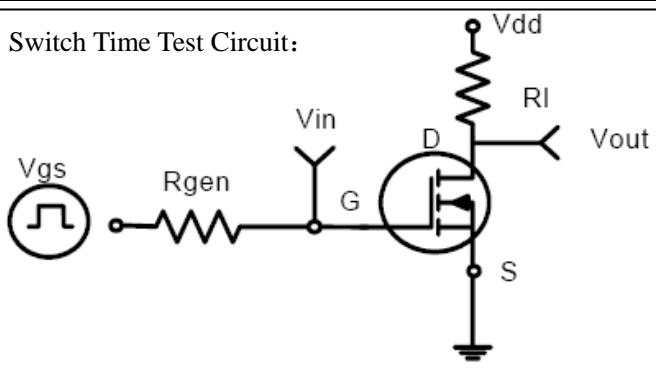
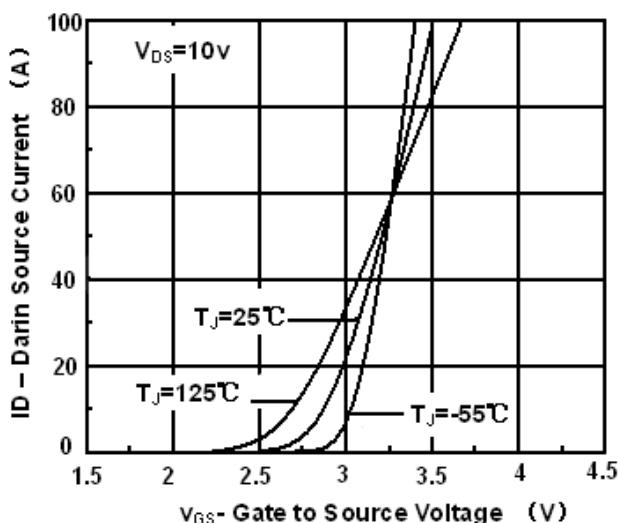
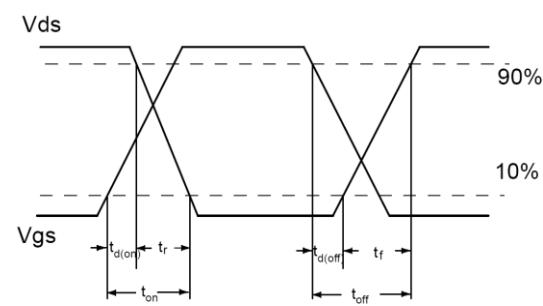
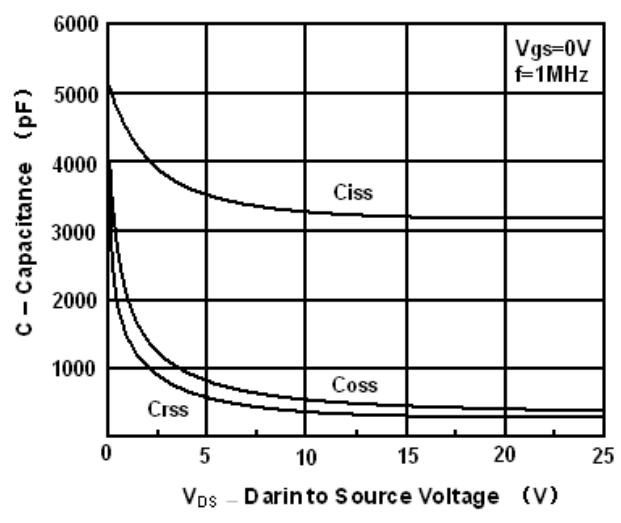
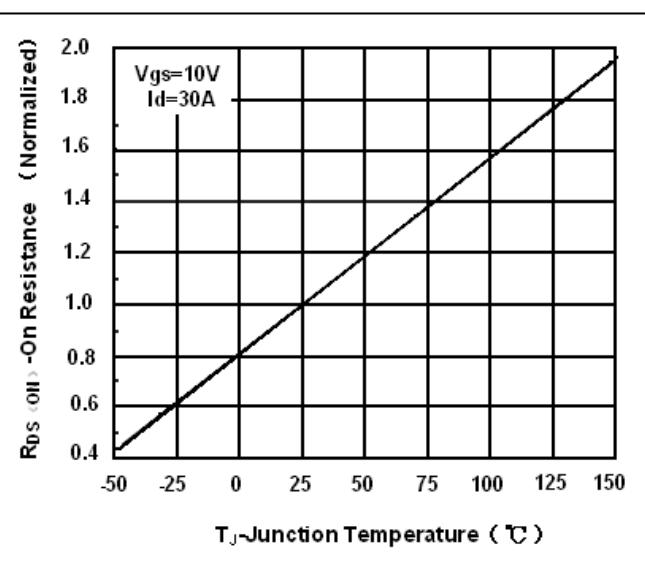
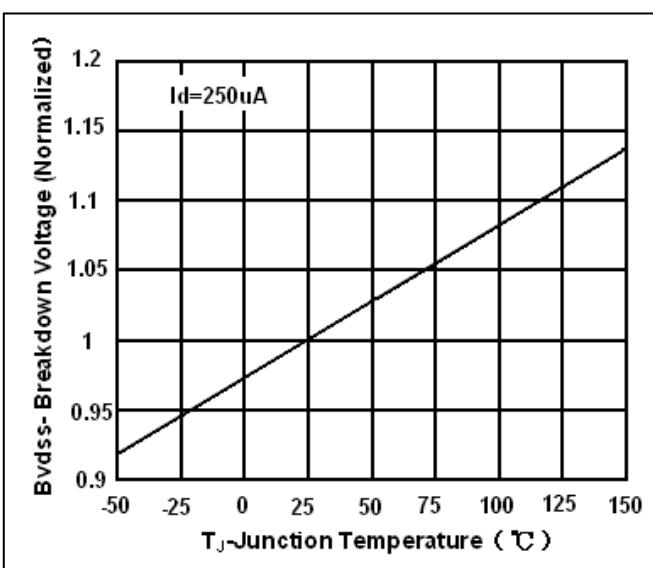
- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Test condition: L = 0.3mH, ID = 37A, V<sub>DD</sub> = 30V
- ③ Pulse width≤300μs, duty cycle≤1.5% ; RG = 25Ω Starting TJ = 25°C

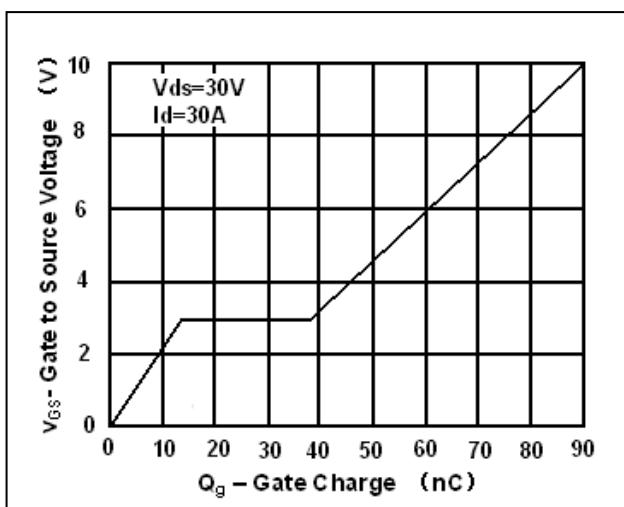
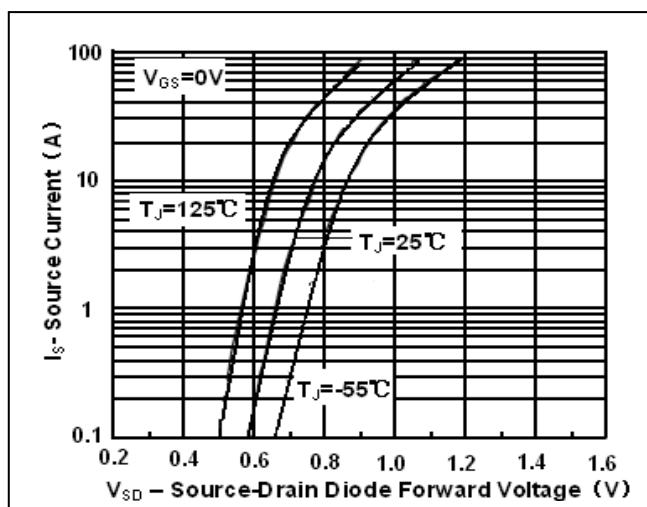
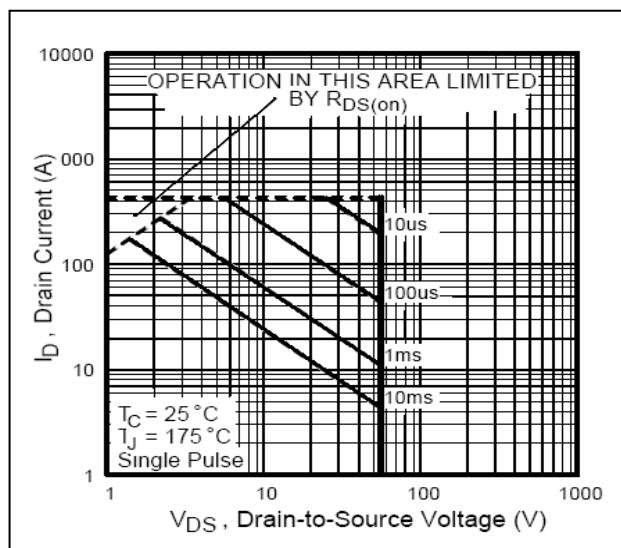
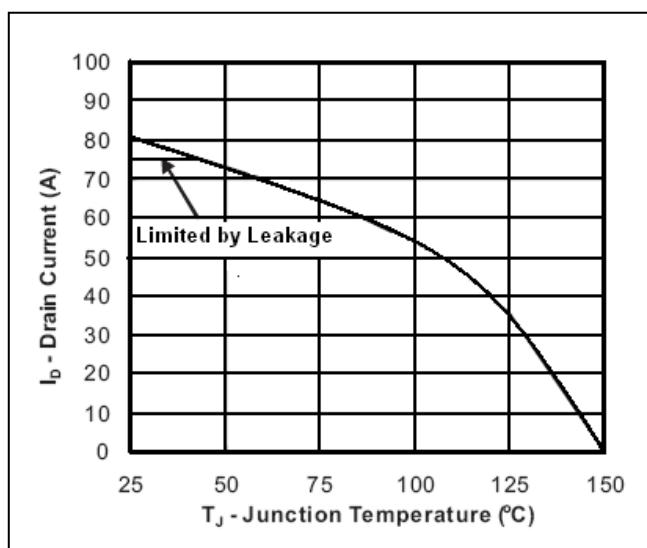
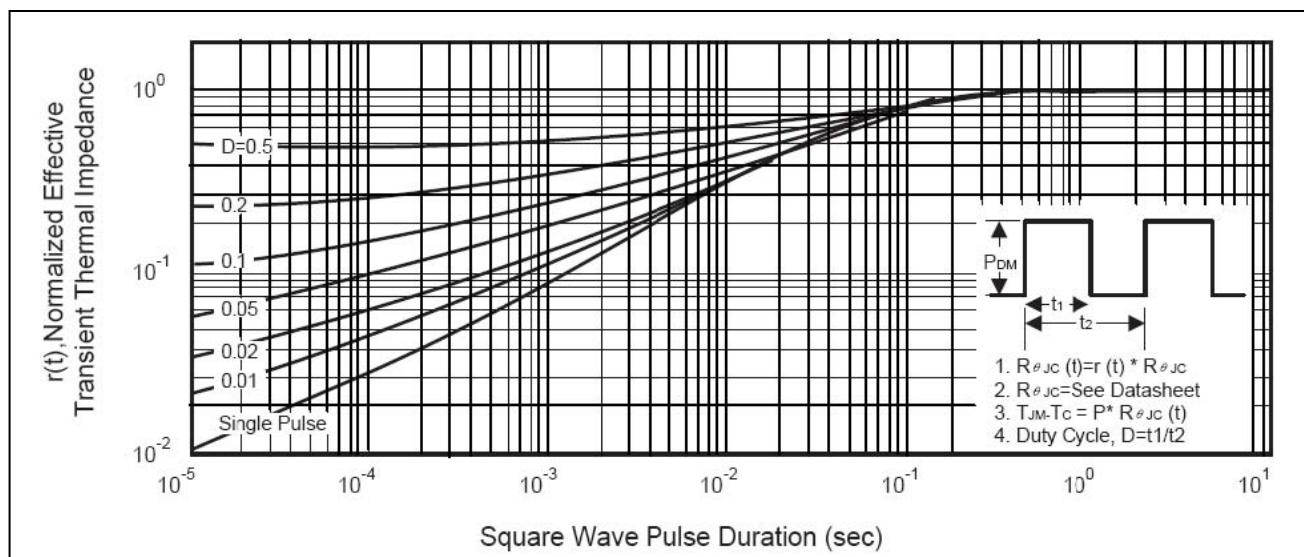
EAS test circuit:



Gate charge test circuit:



**Switch Time Test Circuit:**

**Switch Waveforms:**

**Figure1:Transfer Characteristic**

**Figure2:Capacitance**

**Figure3:On Resistance vs. Junction Temperature**

**Figure4:Breakdown Voltage vs. Junction Temperature**


**Figure5:Gate Charge**

**Figure6:Source-Drain Diode Forward Voltage**

**Figure7:Safe Operation**

**Figure8:Max Drain Current vs. Junction Temperature**

**Figure9:Transient Thermal Impedance Curve**

**TO-263 MECHANICAL DATA:**

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			

